

Application No.	Applicant(s)
10/080,034	VAN ANTWERP ET AL.
Examiner	Art Unit
B. Dell Chism	1654

SEARCHED					
Class	Subclass	Date	Examiner		
514	13,3,	9-27-04	Ø		
530	303				
530	303 364 325				
. 100					

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
\$14	13,3,	9-27-04	0			
532	303, 304 325					

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY	')
	DATE	EXMR
STN, WEST, INVENTOR SEARCH	9-27-04	BDC